

Notice of References Cited	Application/Control No. 10/525,932		Applicant(s)/Patent Under Reexamination DODDRELL ET AL.	
	Examiner Tiffany A. Fetzner		Art Unit 2859	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,900,636	05-2005	Leussler, Christoph Guenther	324/318
*	B	US-2004/0155656 A1	08-2004	Leussler, Christoph Guenther	324/318
*	C	US-6,870,368 B2	03-2005	Visser et al.	324/318
*	D	US-2002/0125888 A1	09-2002	Visser et al.	324/318
*	E	US-2006/0119358 A1	06-2006	Doddrell et al.	324/318
*	F	US-7,109,713 B2	09-2006	Okamoto et al.	324/318
*	G	US-2005/0264292 A1	12-2005	Okamoto et al.	324/318
*	H	US-2005/0122113 A1	06-2005	Okamoto et al.	324/318
*	I	US-6,998,843 B2	02-2006	Okamoto et al.	324/318
*	J	US-6,930,481 B2	08-2005	Okamoto et al.	324/318
*	K	US-2003/0094948 A1	05-2003	Okamoto et al.	324/318
*	L	US-2006/0181279 A1	08-2006	Okamoto et al.	324/318
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.